Record Nr. UNINA9910299938503321 Autore Prinzie Jeffrey Titolo Radiation Hardened CMOS Integrated Circuits for Time-Based Signal Processing // by Jeffrey Prinzie, Michiel Steyaert, Paul Leroux Pubbl/distr/stampa Cham:,: Springer International Publishing:,: Imprint: Springer,, 2018 **ISBN** 3-319-78616-4 Edizione [1st ed. 2018.] Descrizione fisica 1 online resource (205 pages) Collana Analog Circuits and Signal Processing, , 1872-082X Disciplina 621.3815 Soggetti Electronic circuits Signal processing Image processing Speech processing systems Electronics Microelectronics Circuits and Systems Signal, Image and Speech Processing Electronics and Microelectronics, Instrumentation Lingua di pubblicazione Inglese **Formato** Materiale a stampa Livello bibliografico Monografia Introduction -- Radiation Effects in CMOS Technology -- Time-Domain Nota di contenuto Signal Processing -- Clock Synthesizers -- Single Shot Time-to-Digital Converters -- Low Jitter Clock Generators -- Radiation experiments on CMOS PLLs -- Radiation Hard Frequency Synthesizers -- Conclusion. This book presents state-of-the-art techniques for radiation hardened Sommario/riassunto high-resolution Time-to-Digital converters and low noise frequency synthesizers. Throughout the book, advanced degradation mechanisms and error sources are discussed and several ways to prevent such errors are presented. An overview of the prerequisite physics of nuclear interactions is given that has been compiled in an easy to understand chapter. The book is structured in a way that different hardening techniques and solutions are supported by theory and experimental data with their various tradeoffs. Based on leading-edge research,

conducted in collaboration between KU Leuven and CERN, the European

Center for Nuclear Research Describes in detail advanced techniques to harden circuits against ionizing radiation Provides a practical way to learn and understand radiation effects in time-based circuits Includes an introduction to the underlying physics, circuit design, and advanced techniques accompanied with experimental data.